

**Search Notes**

Application/Control No.

10/635,669

Examiner

Wen-Tai Lin

Applicant(s)/Patent under  
Reexamination

CIRNE ET AL.

Art Unit

2154

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Limited text search on EAST (See printout)	5/9/07	wte